Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/975,841	SMITH ET AL.		
Examiner	Art Unit		
Nauven Nao	2616		

SEARCHED					
Class	Subclass	Date	Examiner		
370	465	2/16/2007	NHN		
370	466	2/16/2007	NHN		
370	907	2/16/2007	NHN		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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	DATE	EXMR		
Consulted SPE Wing Chan	2/16/2007 [.]	NHN		
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